Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/038,011	CHANG, SANG-WOON
Examiner	Art Unit
YOSEF KASSA	2625

	SEARCHED				
Class	Subclass	Date	Examiner		
382	282	7/19/2005	YK		
382	284	7/19/2005	YK		
382	294	7/19/2005	YK		
358	538	7/19/2005	YK		
358	540	7/19/2005	YK		
358	450	7/19/2005	YK		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (US-PAT, PG-PUB), IEEE and inventor searched	7/19/2005	YK		
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